118dB (typ)



LME49721 High Performance, High Fidelity Rail-to-Rail Input/Output Audio Operational Amplifier

General Description

The LME49721 is a low distortion, low noise Rail-to-Rail Input/ Output operational amplifier optimized and fully specified for high performance, high fidelity applications. Combining advanced leading-edge process technology with state-of-the-art circuit design, the LME49721 Rail-to-Rail Input/Output operational amplifier delivers superior signal amplification for outstanding performance. The LME49721 combines a very high slew rate with low THD+N to easily satisfy demanding applications. To ensure that the most challenging loads are driven without compromise, the LME49721 has a high slew rate of $\pm 8.5V/\mu$ s and an output current capability of ± 9.7 mA. Further, dynamic range is maximized by an output stage that drives $10k\Omega$ loads to within 10mV of either power supply voltage.

The LME49721 has a wide supply range of 2.2V to 5.5V. Over this supply range the LME49721's input circuitry maintains excellent common-mode and power supply rejection, as well as maintaining its low input bias current. The LME49721 is unity gain stable.

Key Specifications

Power Supply Voltage Range	2.2V to 5.5V
Quiescent Current	2.15mA (typ)
THD+N ($A_V = 2, V_{OUT} = 4V_{p-p}, f_{IN} =$	1kHz)
$R_L = 2k\Omega$	0.00008% (typ)
R _L = 600Ω	0.0001% (typ)
Input Noise Density	4nV/√ Hz (typ), @ 1kHz
Slew Rate	±8.5V/µs (typ)

- Gain Bandwidth Product
 20MHz (typ)
- Open Loop Gain (R_L = 600Ω)
- Input Bias Current
 40fA (typ)
- Input Offset Voltage 0.3mV (typ)
- PSRR 103dB (typ)

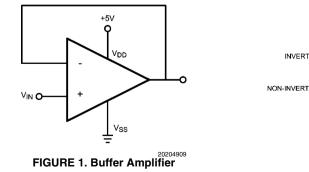
Features

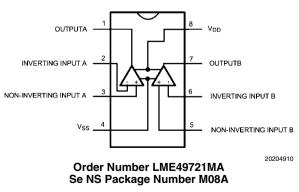
- Rail-to-rail Input and Output
- Easily drives 10kΩ loads to within 10mV of each power supply voltage
- Optimized for superior audio signal fidelity
- Output short circuit protection

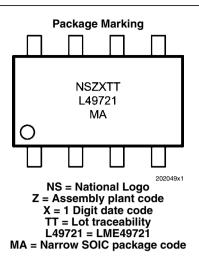
Applications

- Ultra high quality portable audio amplification
- High fidelity preamplifiers
- High fidelity multimedia
- State of the art phono pre amps
- High performance professional audio
- High fidelity equalization and crossover networks
- High performance line drivers
- High performance line receivers
- High fidelity active filters
- DAC I–V converter
- ADC front-end signal conditioning

Typical Connection, Pinout, and Package Marking







Absolute Maximum Ratings (Notes 1, 2)

If Military/Aerospace specified devices are required, please contact the National Semiconductor Sales Office/ Distributors for availability and specifications.

Distributors for availability a	nd specifications.	Junction Temperature	150°C
Power Supply Voltage		Thermal Resistance	
$(V_{\rm S} = V^+ - V^-)$	6V	θ _{JA} (SO)	165°C/W
Storage Temperature	–65°C to 150°C	Temperature Range	
Input Voltage	(V-) - 0.7V to (V+) + 0.7V	$T_{MIN} \le T_A \le T_{MAX}$	$-40^{\circ}C \le T_A \le 85^{\circ}C$
Output Short Circuit (Note 3)	Continuous	Supply Voltage Range	$2.2V \le V_S \le 5.5V$

Power Dissipation

ESD Rating (Note 4)

ESD Rating (Note 5)

			LME49721		
Symbol	Parameter	Conditions	Typical Limit		Units
			(Note 6)	(Note 7)	(LIMITS)
THD+N	Total Harmonic Distortion + Noise	$A_{V} = +1, V_{OUT} = 2V_{p-p},$ $R_{L} = 2k\Omega$	0.0002		
		R _L = 600Ω	0.0002	0.001	% (max)
IMD	Intermodulation Distortion	$A_V = +1, V_{OUT} = 2V_{p-p},$ Two-tone, 60Hz & 7kHz 4:1	0.0004		%
GBWP	Gain Bandwidth Product		20	15	MHz (min
SR	Slew Rate	A _V = +1	8.5		V/µs (min
FPBW	Full Power Bandwidth	$V_{OUT} = 1V_{P.P}, -3dB$ referenced to output magnitude at f = 1kHz	2.2		MHz
t _s	Settling time	A _V = 1, 4V step 0.1% error range	800		ns
	Equivalent Input Noise Voltage	f _{BW} = 20Hz to 20kHz, A-weighted	.707	1.13	μV _{P-P} (max)
e _n	Equivalent Input Noise Density	f = 1kHz A-weighted	4	6	nV/√Hz (max)
i _n	Current Noise Density	f = 10kHz	4.0		fA / √Hz
V _{OS}	Offset Voltage		0.3	1.5	mV (max)
ΔV _{OS} /ΔTemp	Average Input Offset Voltage Drift vs Temperature	$40^{\circ}C \le T_A \le 85^{\circ}C$	1.1		μV/°C
PSRR	Average Input Offset Voltage Shift vs Power Supply Voltage		103	85	dB (min)
ISO _{CH-CH}	Channel-to-Channel Isolation	f _{IN} = 1kHz	117		dB
I _B	Input Bias Current	$V_{CM} = V_S/2$	40		fA
ΔI _{OS} /ΔTemp	Input Bias Current Drift vs Temperature	$-40^{\circ}C \le T_A \le 85^{\circ}C$	48		fA/°C
I _{OS}	Input Offset Current	$V_{CM} = V_S/2$	60		fA
V _{IN-CM}	Common-Mode Input Voltage Range			(V+) - 0.1 (V-) + 0.1	V (min)
CMRR	Common-Mode Rejection	$V_{SS} - 100mV < V_{CM} < V_{DD} + 100mV$	93	70	dB (min)
	1/f Corner Frequency		2000		Hz
		V_{SS} - 200mV < V_{OUT} < V_{DD} + 200mV			
٨	Open Loop Voltage Gain	R _L = 600Ω	118	100	dB (min)
A _{VOL}		$R_L = 2k\Omega$	122		dB (min)
		$R_L = 10k\Omega$	130	115	dB (min)

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200V

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	Parameter	Conditions	LME	LME49721	
Symbol			Typical	Limit	Limit Units
			(Note 6)	(Note 7)	(Limits)
$R_{L} = 600\Omega$		D 0000	$V_{DD} - 30mV$	V _{DD} – 80mV	V (min)
	$R_L = 60002$	V _{SS} + 30mV	V _{SS} + 80mV	V (min)	
V _{OUTMIN}	Output Voltage Swing	$R_{L} = 10k\Omega, V_{S} = 5.0V$	V _{DD} – 10mV	$V_{DD} - 20mV$	V (min)
			V _{SS} + 10mV	V _{SS} + 20mV	V (min)
I _{OUT}	Output Current	R_{L} = 250 Ω , V_{S} = 5.0V	9.7	9.3	mA (min)
I _{OUT-SC}	Short Circuit Current		100		mA
		f _{IN} = 10kHz			
R _{OUT}	Output Impedance	Closed-Loop	0.01		Ω
		Open-Loop	46		
Is	Quiescent Current per Amplifier	I _{OUT} = 0mA	2.15	3.25	mA (max)

Note 1: "Absolute Maximum Ratings" indicate limits beyond which damage to the device may occur, including inoperability and degradation of device reliability and/or performance. Functional operation of the device and/or non-degradation at the Absolute Maximum Ratings or other conditions beyond those indicated in the Recommended Operating Conditions is not implied. The Recommended Operating Conditions indicate conditions at which the device is functional and the device should not be operated beyond such conditions. All voltages are measured with respect to the ground pin, unless otherwise specified

Note 2: The *Electrical Characteristics* tables list guaranteed specifications under the listed *Recommended Operating Conditions* except as otherwise modified or specified by the *Electrical Characteristics Conditions* and/or Notes. Typical specifications are estimations only and are not guaranteed.

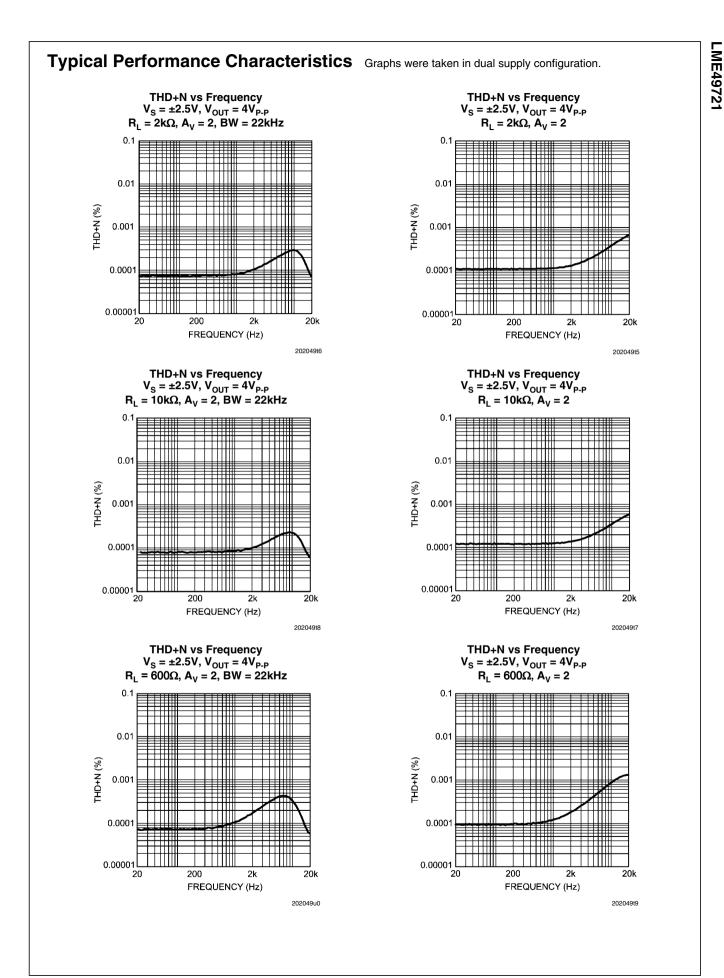
Note 3: The maximum power dissipation must be derated at elevated temperatures and is dictated by T_{JMAX} , θ_{JA} , and the ambient temperature, T_A . The maximum allowable power dissipation is $P_{DMAX} = (T_{JMAX} - T_A) / \theta_{JA}$ or the number given in *Absolute Maximum Ratings*, whichever is lower.

Note 4: Human body model, applicable std. JESD22-A114C.

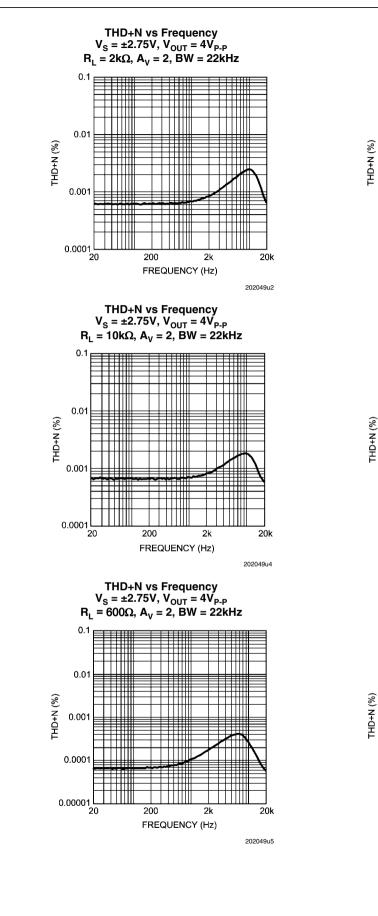
Note 5: Machine model, applicable std. JESD22-A115-A.

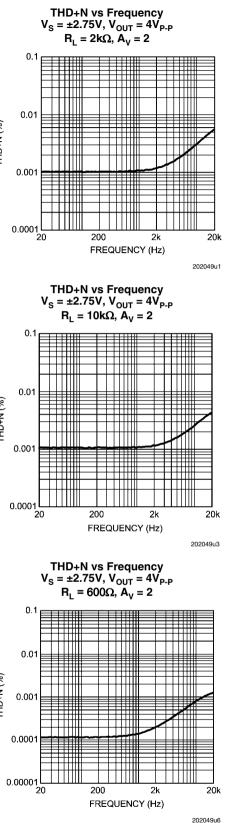
Note 6: Typical values represent most likely parametric norms at $T_A = +25^{\circ}C$, and at the *Recommended Operation Conditions* at the time of product characterization and are not guaranteed.

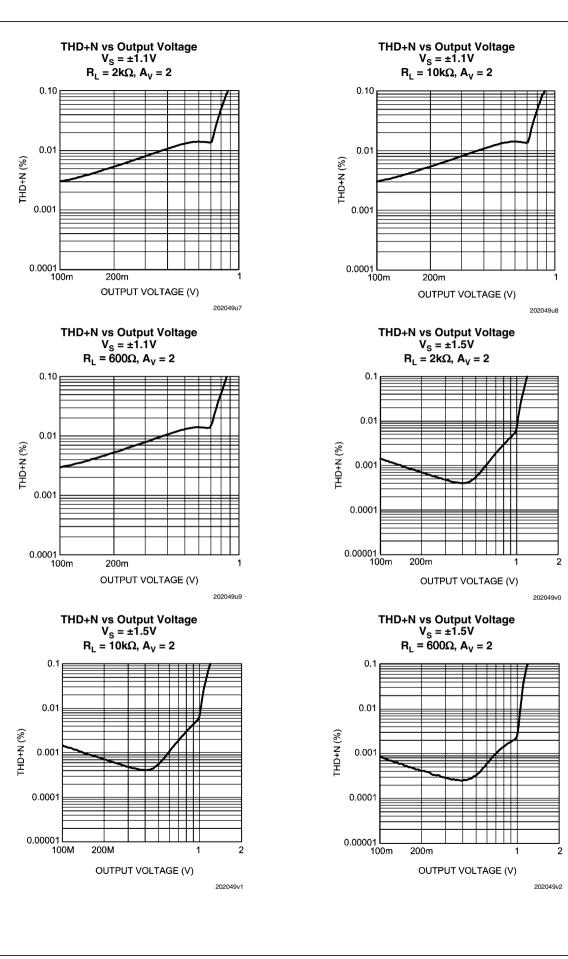
Note 7: Datasheet min/max specification limits are guaranteed by test or statistical analysis.



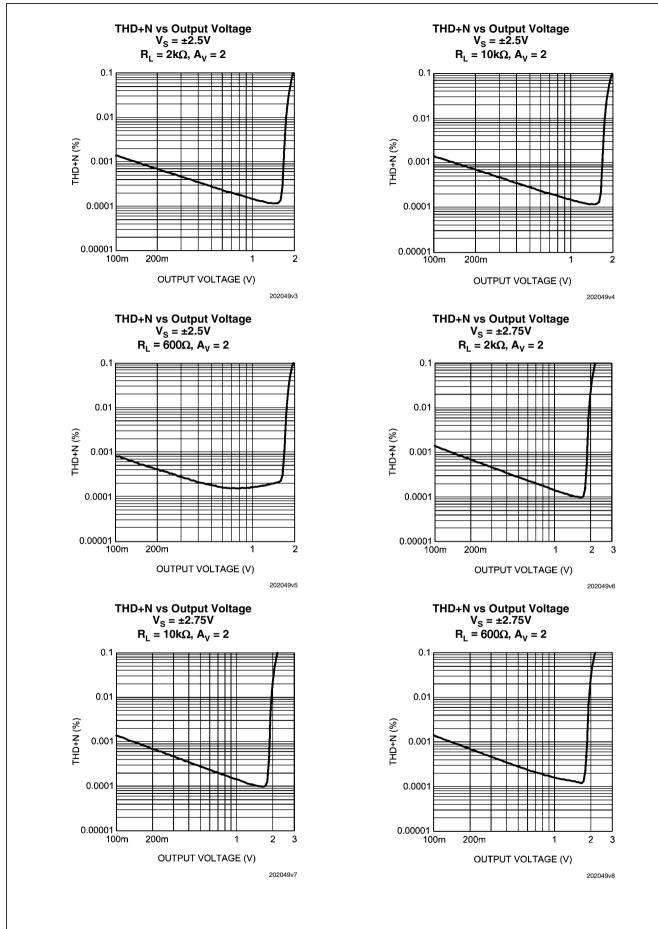
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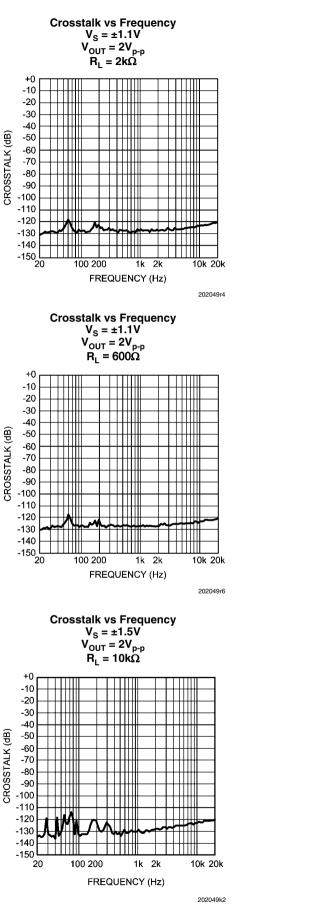


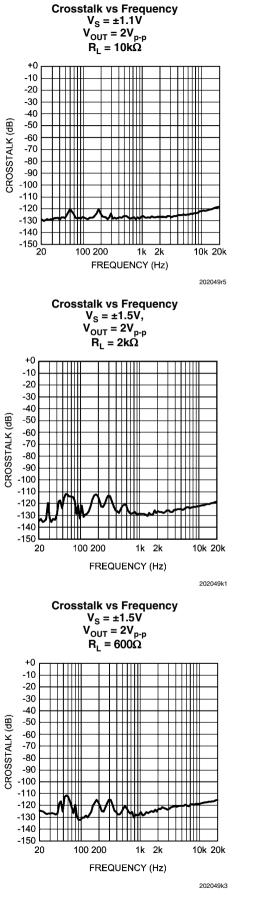


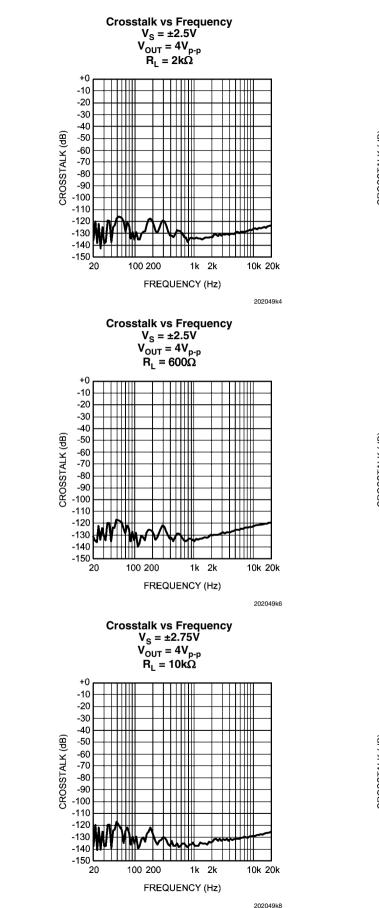


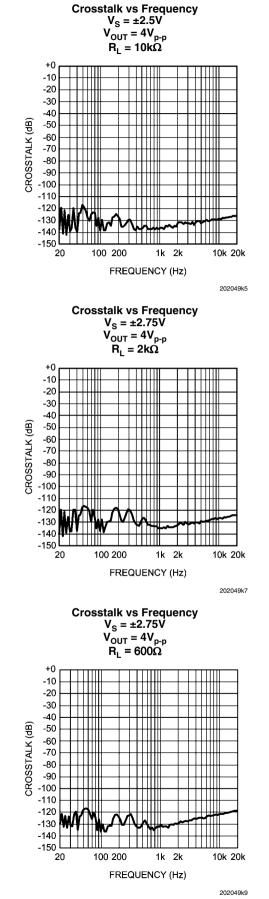


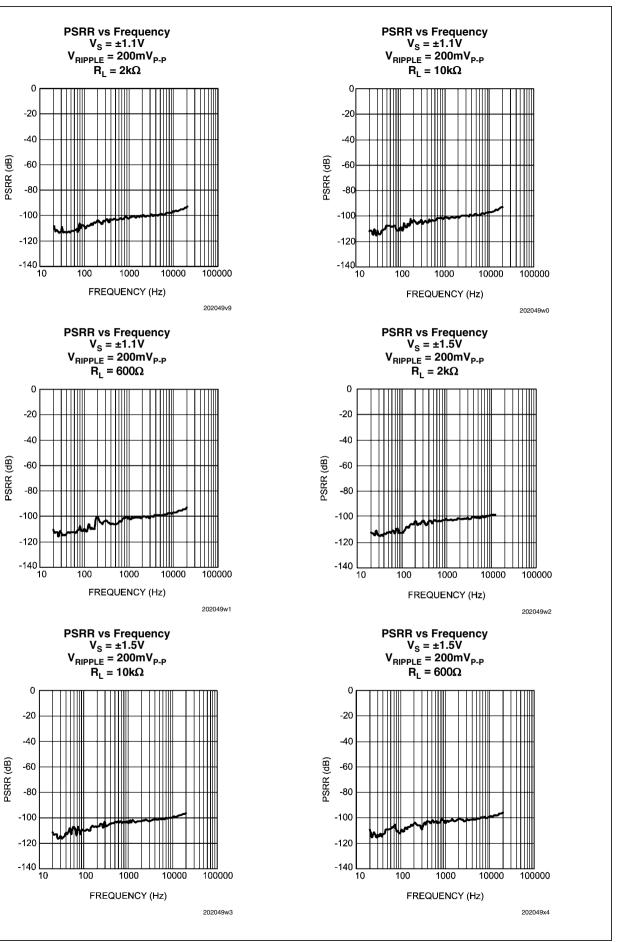


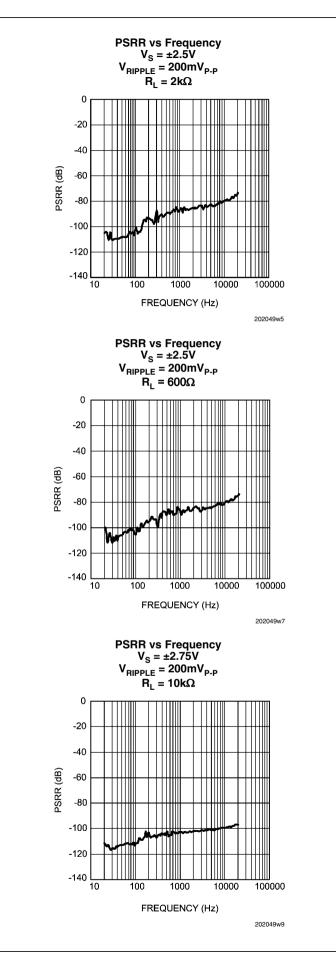


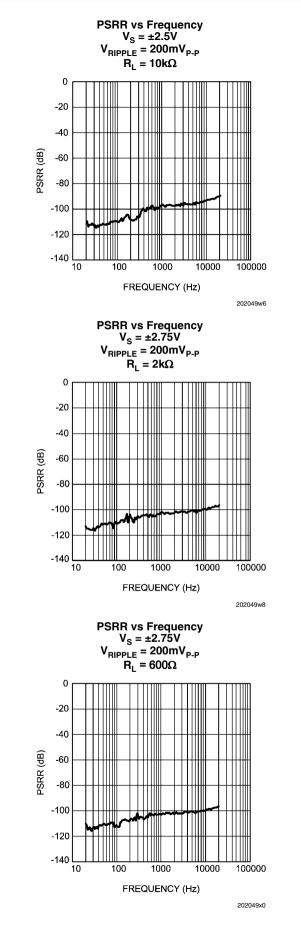


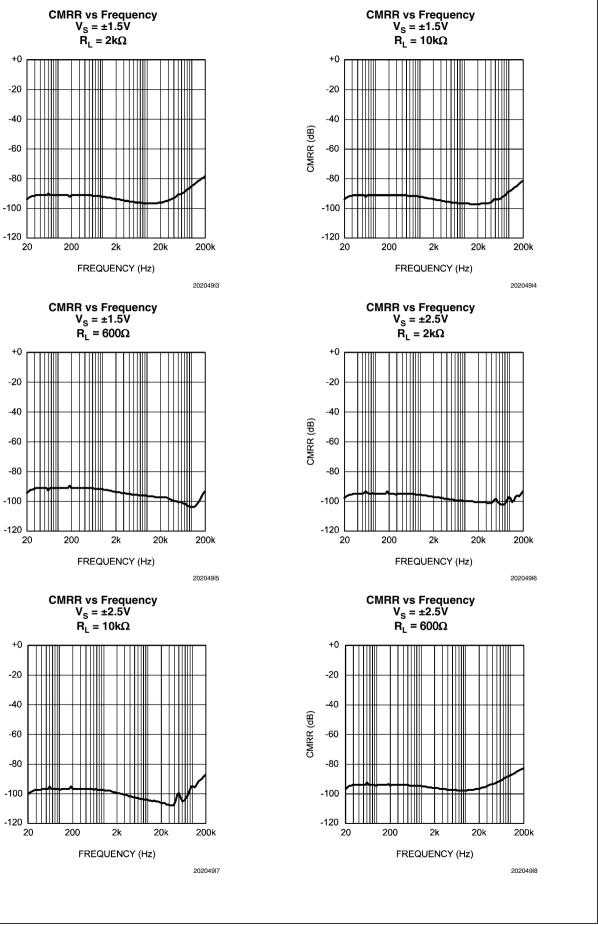








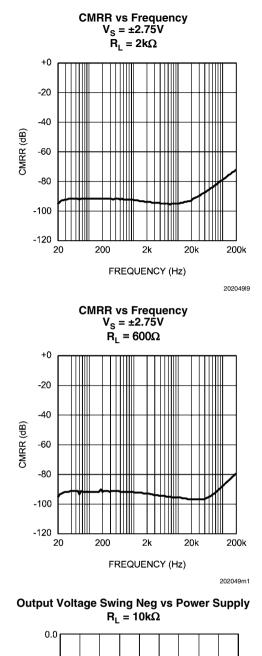


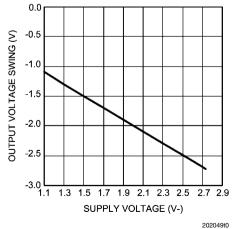


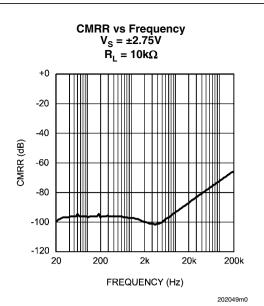
CMRR (dB)

CMRR (dB)

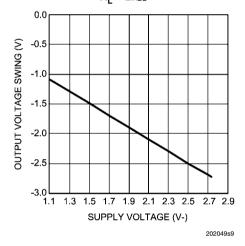
CMRR (dB)



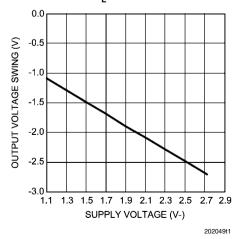




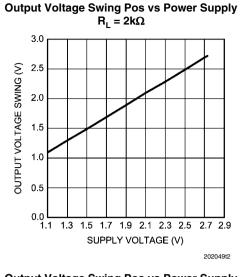
Output Voltage Swing Neg vs Power Supply $R_{L}^{}$ = 2k $\!\Omega$

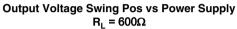


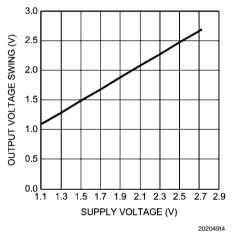
Output Voltage Swing Neg vs Power Supply $R_{I} = 600\Omega$



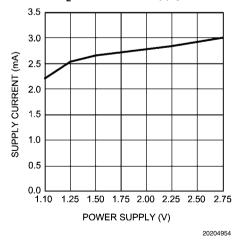
LME49721



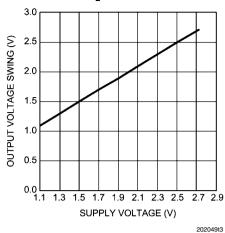




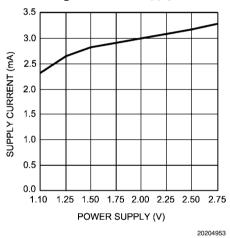
Supply Current per amplifier vs Power Supply $R_I = 10k\Omega$, Dual Supply



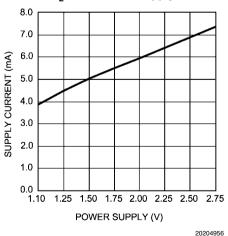
Output Voltage Swing Pos vs Power Supply $R_L = 10k\Omega$



Supply Current per amplifier vs Power Supply $R_1 = 2k\Omega$, Dual Supply



Supply Current per amplifier vs Power Supply $R_i = 600\Omega$, Dual Supply



Application Information

DISTORTION MEASUREMENTS

The vanishingly low residual distortion produced by LME49721 is below the capabilities of all commercially available equipment. This makes distortion measurements just slightly more difficult than simply connecting a distortion meter to the amplifier's inputs and outputs. The solution. however, is quite simple: an additional resistor. Adding this resistor extends the resolution of the distortion measurement equipment.

The LME49721's low residual is an input referred internal error. As shown in Figure 1, adding the 10Ω resistor connected between athe amplifier's inverting and non-inverting inputs

changes the amplifier's noise gain. The result is that the error signal (distortion) is amplified by a factor of 101. Although the amplifier's closed-loop gain is unaltered, the feedback available to correct distortion errors is reduced by 101. To ensure minimum effects on distortion measurements, keep the value of R1 low as shown in Figure 1.

This technique is verified by duplicating the measurements with high closed loop gain and/or making the measurements at high frequencies. Doing so, produces distortion components that are within equipments capabilities. This datasheet's THD+N and IMD values were generated using the above described circuit connected to an Audio Precision System Two Cascade.

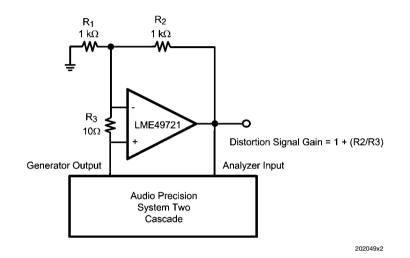


FIGURE 1. THD+N and IMD Distortion Test Circuit with $A_v = 2$

OPERATING RATINGS AND BASIC DESIGN GUIDELINES

The LME49721 has a supply voltage range from +2.2V to +5.5V single supply or ± 1.1 to $\pm 2.75V$ dual supply.

Bypassed capacitors for the supplies should be placed as close to the amplifier as possible. This will help minimize any inductance between the power supply and the supply pins. In addition to a 10μ F capacitor, a 0.1μ F capacitor is also recommended in CMOS amplifiers.

The amplifier's inputs lead lengths should also be as short as possible. If the op amp does not have a bypass capacitor, it may oscillate.

BASIC AMPLIFIER CONFIGURATIONS

The LME49721 may be operated with either a single supply or dual supplies. Figure 2 shows the typical connection for a single supply inverting amplifier. The output voltage for a single supply amplifier will be centered around the commonmode voltage Vcm. Note, the voltage applied to the Vcm insures the output stays above ground. Typically, the Vcm should be equal to $V_{DD}/2$. This is done by putting a resistor divider ckt at this node, see Figure 2.

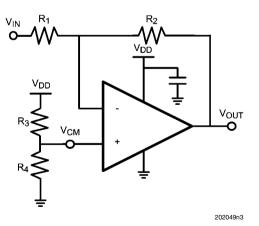


FIGURE 2. Single Supply Inverting Op Amp

Figure 3 shows the typical connection for a dual supply inverting amplifier. The output voltage is centered on zero.

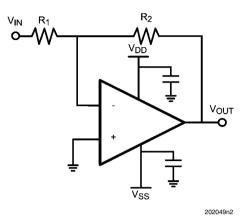
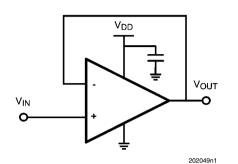
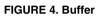


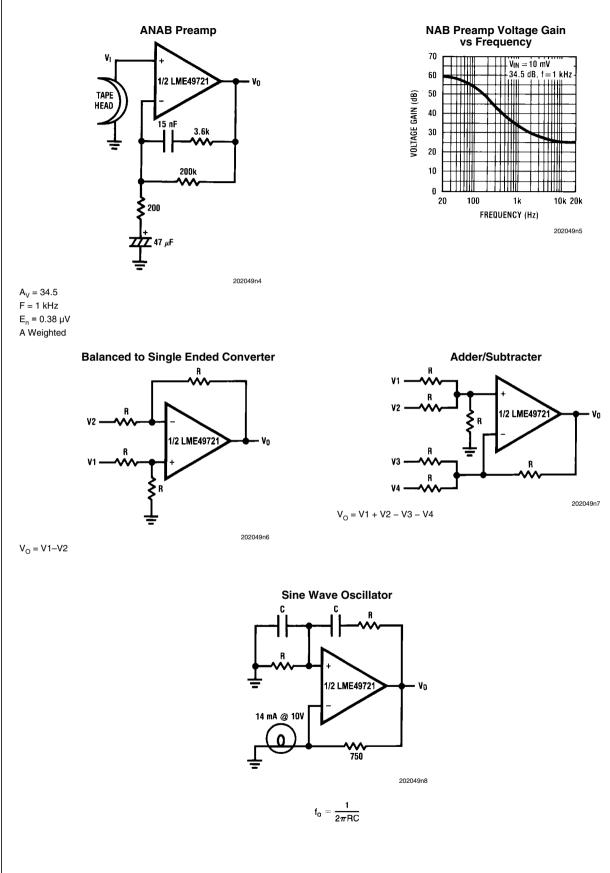
FIGURE 3. Dual Supply Inverting Op Amp

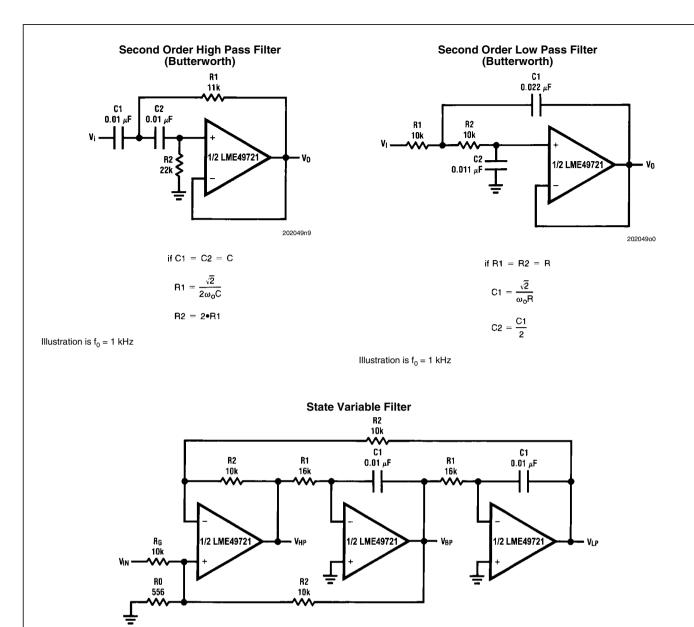
Figure 4 shows the typical connection for the Buffer Amplifier or also called a Voltage Follower. A Buffer Amplifier can be used to solve impedance matching problems, to reduce power consumption in the source, or to drive heavy loads. The input impedance of the op amp is very high. Therefore, the input of the op amp does not load down the source. The output impedance on the other hand is very low. It allows the load to either supply or absorb energy to a circuit while a secondary voltage source dissipates energy from a circuit. The Buffer is a unity stable amplifier, 1V/V. Although the feedback loop is tied from the output of the amplifier to the inverting input, the gain is still positive. Note, if a positive feedback is used, the amplifier will most likely drive to either rail at the output.





Typical Applications

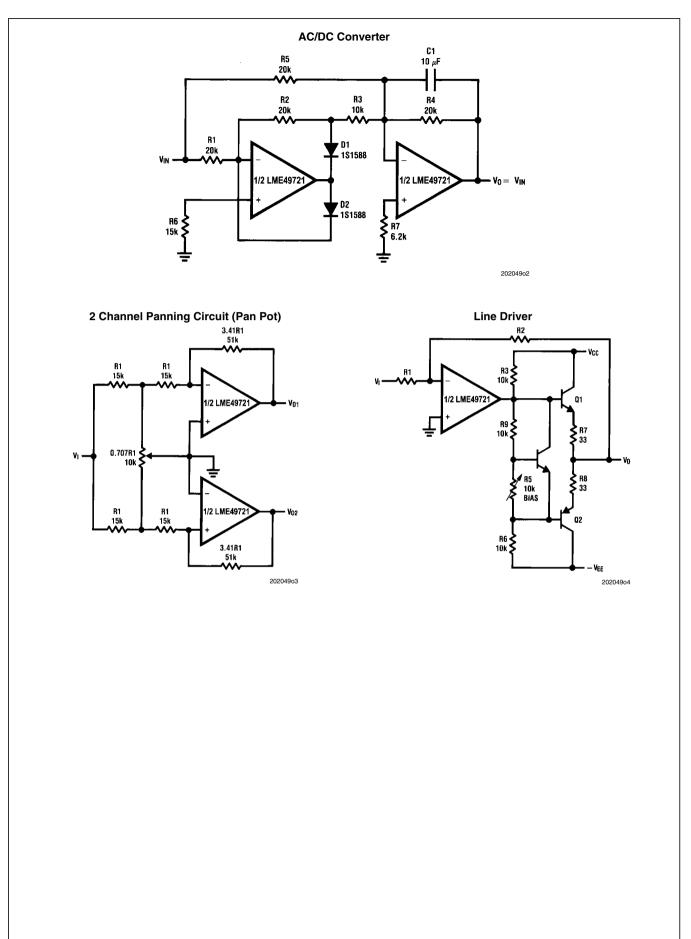


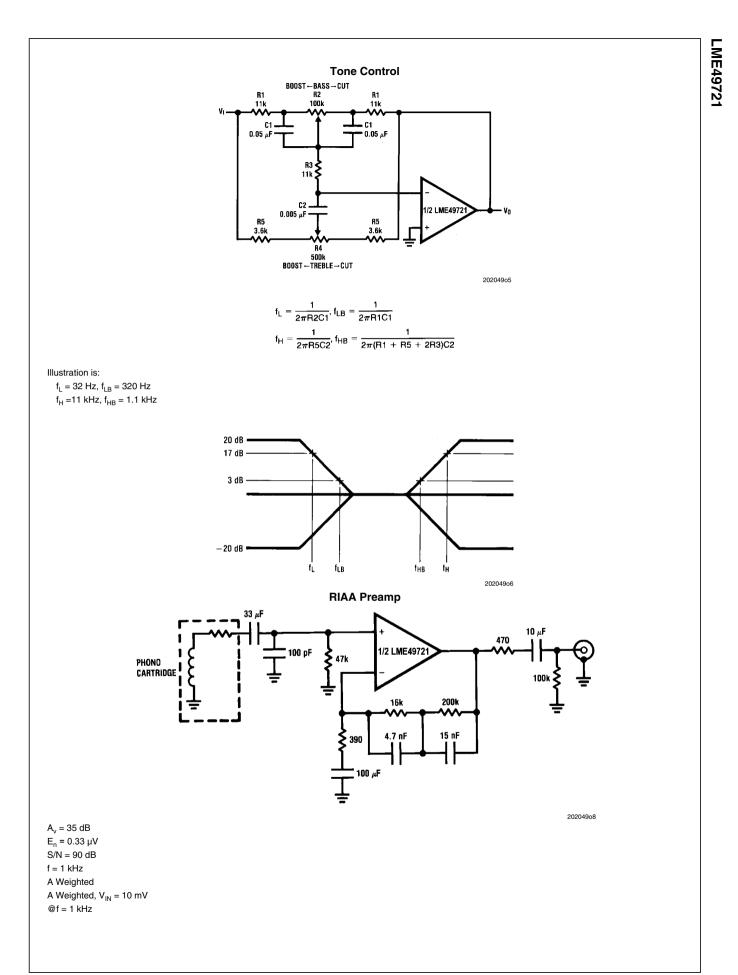


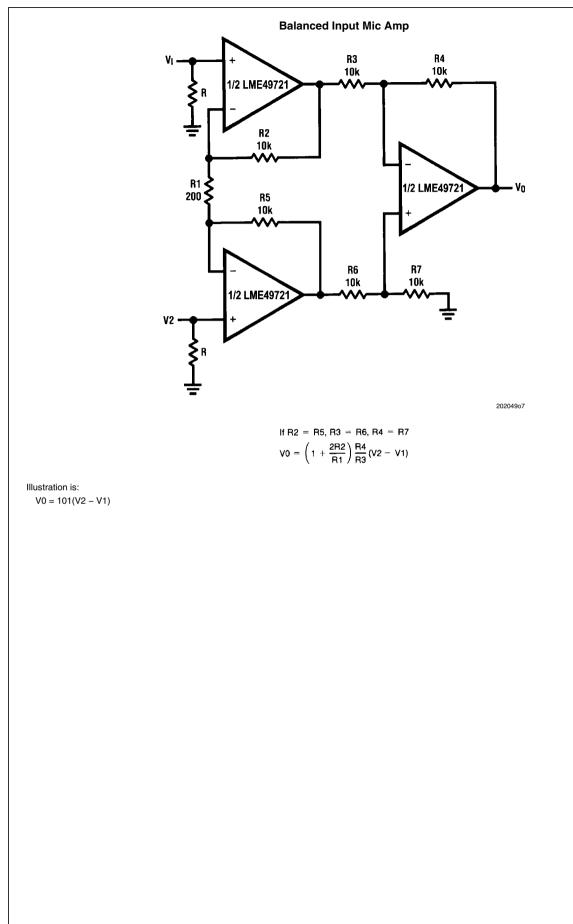
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 $f_0 = \frac{1}{2\pi C 1 R 1}, Q = \frac{1}{2} \left(1 + \frac{R2}{R0} + \frac{R2}{RG} \right), A_{BP} = QA_{LP} = QA_{LH} = \frac{R2}{RG}$

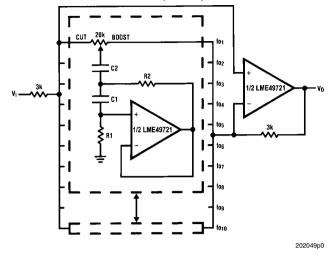
Illustration is $f_0 = 1 \text{ kHz}$, Q = 10, $A_{BP} = 1$







10 Band Graphic Equalizer



fo (Hz)	C ₁	C ₂	R ₁	R ₂
32	0.12µF	4.7µF	75kΩ	500Ω
64	0.056µF	3.3µF	68kΩ	510Ω
125	0.033µF	1.5µF	62kΩ	510Ω
250	0.015µF	0.82µF	68kΩ	470Ω
500	8200pF	0.39µF	62kΩ	470Ω
1k	3900pF	0.22µF	68kΩ	470Ω
2k	2000pF	0.1µF	68kΩ	470Ω
4k	1100pF	0.056µF	62kΩ	470Ω
8k	510pF	0.022µF	68kΩ	510Ω
16k	330pF	0.012µF	51kΩ	510Ω

Note 8: At volume of change = $\pm 12 \text{ dB}$

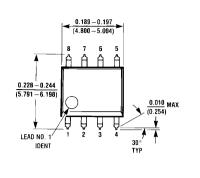
Q = 1.7

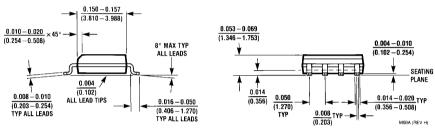
Reference: "AUDIO/RADIO HANDBOOK", National Semiconductor, 1980, Page 2–61

Revision History

Rev	Date	Description
1.0	09/26/07	Initial release.
1.1	10/01/07	Input more info under the Buffer Amplifier.

Physical Dimensions inches (millimeters) unless otherwise noted





NS Package M08A

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